

**Notice of References Cited**

Application/Control No.

10/716,616

Applicant(s)/Patent Under  
Reexamination  
MARQUERING ET AL.

Examiner

MANAV SETH

Art Unit

2624

Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,288,852 A	09-1981	Holland, Steven W.	382/152
*	B	US-4,665,441 A	05-1987	Sakaue et al.	358/448
*	C	US-5,321,768 A	06-1994	Fenrich et al.	382/178
*	D	US-5,335,290 A	08-1994	Cullen et al.	382/176
*	E	US-5,335,298 A	08-1994	Hevenor et al.	382/199
*	F	US-5,430,808 A	07-1995	Baird et al.	382/176
*	G	US-5,555,362 A	09-1996	Yamashita et al.	715/209
*	H	US-5,574,802 A	11-1996	Ozaki, Masaharu	382/176
*	I	US-5,588,072 A	12-1996	Wang, Shin-Ywan	382/176
*	J	US-5,680,478 A	10-1997	Wang et al.	382/176
*	K	US-5,745,596 A	04-1998	Jefferson, Darrell E.	382/176
*	L	US-5,751,850 A	05-1998	Rindtorff, Klaus	382/178
*	M	US-5,848,185 A	12-1998	Koga et al.	382/173

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/716,616		Applicant(s)/Patent Under Reexamination MARQUERING ET AL.	
	Examiner MANAV SETH		Art Unit 2624	Page 2 of 2

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,167,150 A	12-2000	Michael et al.	382/149
*	B	US-2003/0011794 A1	01-2003	Yao et al.	358/1.9
*	C	US-6,577,762 B1	06-2003	Seeger et al.	382/173
*	D	US-6,629,292 B1	09-2003	Corson et al.	716/3
*	E	US-7,336,825 B2	02-2008	Jacobs, Johannes W. M.	382/172
*	F	US-7,421,371 B2	09-2008	Segers et al.	702/183
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.